

**Search Notes**

Application/Control No.

10/731,373

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

BALAN, CHELLAPPA

Art Unit

1745

**SEARCHED**

Class	Subclass	Date	Examiner
429	12	6/5/2007	DWY
429	13	6/5/2007	DWY
429	30	6/5/2007	DWY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/5/2007	DWY